Application/Control No. Applicant(s)/Patent Under Reexamination 10/735,989 MITRA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Leonid M Fastovsky 3742 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-2003/0209534 11-2003 Ferguson, Lucian G. 219/548 В US-6,582,987 06-2003 Jun et al. 438/49 С US-2002/0024662 02-2002 Ueno et al. 356/246 D US-6,165,876 12-2000 Yamazaki et al. 438/517 US-5,464,966 11-1995 Ε Gaitan et al. 219/544 F US-G US-US-Н US-US-J Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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